

Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL			
Type:	Performance report Rev: 1.2			
Orig:		Date:	September 07, 2018	

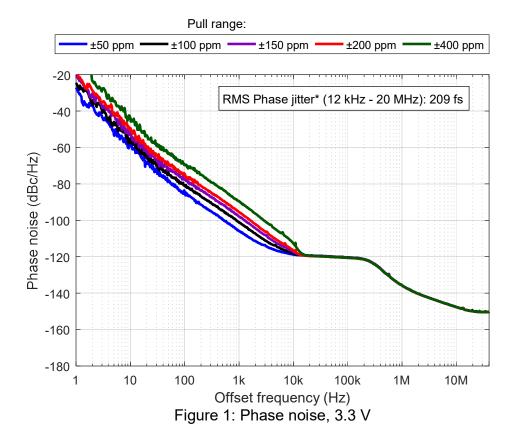
Performance report for SiT3373 - 644.53125 MHz, LVPECL

This performance report contains the following data:

- Phase noise
- Random phase jitter
- Output waveforms
- Pull range linearity
- Frequency stability over temperature
- Period jitter
- Duty cycle
- Rise/Fall time
- Amplitude
- Current consumption



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL			
Type:	Performance report	Rev:	1.2	
Orig:		Date:	September 07, 2018	



*Integrated phase jitter value applies for ±50 ppm to ±400 ppm pull ranges

Table 1: Phase noise

Phase noise dBc/Hz					
Frequency offset	Pull range (ppm)				
(Hz)	±50	±100	±150	±200	±400
1	-27.0	-24.5	-19.7	-18.3	-13.0
10	-59.2	-57.4	-51.3	-49.4	-43.8
100	-84.4	-81.2	-77.2	-74.5	-69.5
1 K	-105.9	-101.1	-97.9	-95.5	-89.5
10 K	-118.8	-118.2	-117.4	-116.6	-112.7
100 K	-120.4	-120.4	-120.4	-120.6	-120.6
1 M	-135.8	-135.7	-135.8	-135.8	-135.8
10 M	-147.7	-147.6	-147.7	-147.7	-147.6
40 M	-150.3	-150.1	-150.2	-150.2	-150.3

5451 Patrick Henry Drive, Santa Clara, California 95054 • 408.328.4400 • sitime.com

Page 2 of 10



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL			
Type:	Performance report Rev: 1.2			
Orig:		Date:	September 07, 2018	

Table 2: Integrated Phase jitter

Parameter	Units	Pull range (ppm)	
Parameter	Utills	±50 to ±400	
Integrated Phase jitter (1.875 MHz - 20 MHz)	fs, rms	71	
Integrated Phase jitter (12 kHz - 20 MHz)	fs, rms	209	



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL			
Type:	Performance report Rev: 1.2			
Orig:		Date:	September 07, 2018	



Figure 2: Output waveform, 2.5 V



Figure 3: Output waveform, 3.3 V

5451 Patrick Henry Drive, Santa Clara, California 95054 • 408.328.4400 • sitime.com

Page 4 of 10



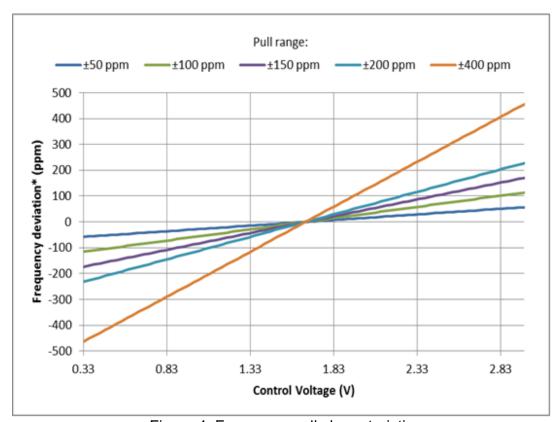


Figure 4: Frequency pull characteristic



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL		
Type:	Performance report	Rev:	1.2
Orig:		Date:	September 07, 2018

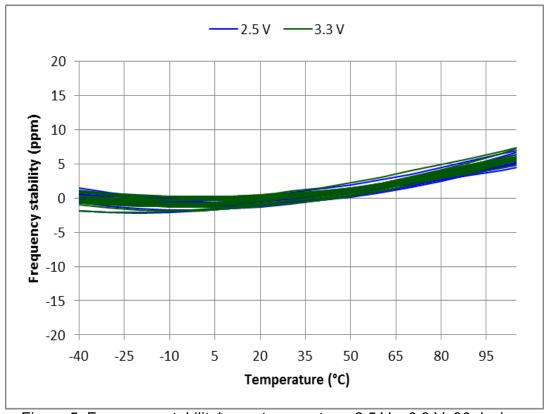


Figure 5: Frequency stability* over temperature, 2.5 V – 3.3 V, 30 devices

*SiT3373 frequency stability is independent of output frequency.



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL		
Type:	Performance report	Rev:	1.2
Orig:		Date:	September 07, 2018

Table 3: Summary performance data

Parameter	Units	Voltage		
Parameter	Utilits	2.5 V	3.3 V	
Period jitter	ps, rms	1.03	1.04	
Period jitter (sample size 10,000 cycles)	ps, pk-pk	7.99	8.01	
Duty cycle	%	50.5	50.6	
Rise time (20% - 80%)	ps	219	210	
Fall time (80% - 20%)	ps	216	208	
Differential voltage swing	V	1.49	1.48	
Current consumption (no load, output enabled)	mA	77.9	78.3	
Current consumption (no load, output disabled)	mA	54.0	54.1	



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL			
Type:	Performance report Rev: 1.2			
Orig:		Date:	September 07, 2018	

Test description

Conditions:

- Frequency: 644.53125 MHz

- VDD: 2.5 V, 3.3 V

- Pull range: ±50 ppm, ±100 ppm, ±150 ppm, ±200 ppm, ±400 ppm

- Temperature: 25 °C

Equipment:

Model	Measurement / Purpose
Keysight DSA90604A (6 GHz,	Period jitter, output amplitude, rise/fall time,
20 Gsps)	duty cycle
Keysight 5052B Signal Source	Phase noise, integrated phase jitter
Analyzer	
Keysight 34980A	Power supply current
Keysight E3631A	Power supply
Keysight 53230A	Frequency



Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL		
Type:	Performance report	Rev:	1.2
Orig:		Date:	September 07, 2018

Setup

Waveform

For waveform parameters measurement (rise/fall time, differential swing, duty cycle), both DUT outputs are terminated with 50 Ω to VDD - 2 V. Output signals are measured using Keysight 1134B active probe with Keysight N5425B probe head. All measurements are applied to the differential waveform. Figure 6 shows test setup diagram for waveform parameters measurement.

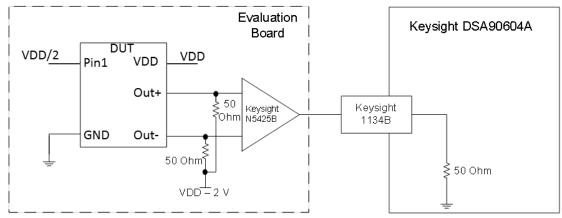


Figure 6. Test setup for measuring waveform parameters (rise/fall time, differential swing, duty cycle)

Period Jitter

For period jitter measurement output is terminated with 50 Ω to VDD – 2 V at the input of hi-speed comparator (ADCMP581). AC coupled comparator's output is connected to oscilloscope channel. Figure 7 shows test setup diagram for period jitter measurement.

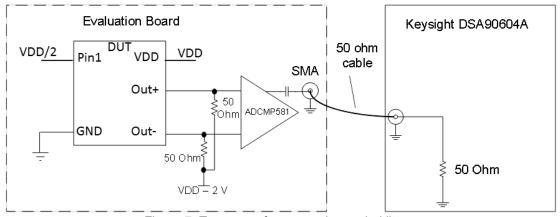


Figure 7. Test setup for measuring period jitter

5451 Patrick Henry Drive, Santa Clara, California 95054 • 408.328.4400 • sitime.com

Page 9 of 10

Si Time	Title:	Performance report for SiT3373, 644.53125 MHz, LVPECL		
	Type:	Performance report	Rev:	1.2
	Orig:		Date:	September 07, 2018

Phase noise

For phase noise measurements, differential signal is converted to single-ended using impedance matching transformer. Transformer's output is connected to measurement instrument. Figure 8 shows test setup diagram for phase noise measurement.

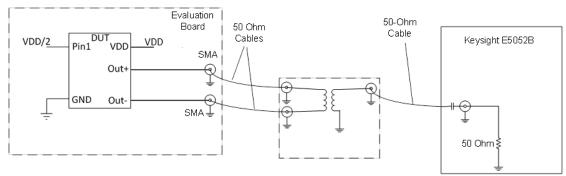


Figure 8. Test setup for measuring phase noise.

Current consumption

For Current consumption measurement device output is floating. For frequency measurement differential-to-single-ended converter is used.